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Date of issue...... Apr. 13, 2021

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Testing Laboratory..... Shenzhen ZKT Technology Co., Ltd.

Address...... 1/F, No. 101, Building B, No. 6, Tangwei Community Industrial

Avenue, Fuhai Street, Bao'an District, Shenzhen, China

Applicant's name..... Elitech Technology, Inc.

Test Report Form No.....: --

Test Standards..... EN 300 328 V2.2.2 (2019-07)

Test Report Form(s) Originator.....: ZKT Testing

Master TRF...... Dated: 2017-06

The test report is effective only with both signature and specialized stamp. This result(s) shown in this report refer only to the sample(s) tested. Without written approval of Shenzhen ZKT Technology Co., Ltd., this report can't be reproduced except in full. The tested sample(s) and the sample information are provided by the client.

Test item description.....: manifold gauge

Trade Mark..... N/A

Manufacturer..... Jiangsu Jingchuang Electronics Co.,Ltd.

Development Zone, Xuzhou, Jiangsu, China

Model/Type reference : EMG-40V

MS-1000, MS-1000S, MS-2000, MS-2000S, MS-3000, MS-3000S,

MS-4000, MS-4000S, EMG-10V, EMG-10VW, EMG-20V, EMG-20VW, EMG-30V, EMG-30VW, EMG-40VW

Ratings...... Input: 5V===2A,

DC3.7V 5000mAh by battery









Testing procedure and testing location:	
Testing Laboratory:	Shenzhen ZKT Technology Co., Ltd.
Address:	1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China
Date of Test:	Apr. 08, 2021 to Apr. 13, 2021
Tested by (name + signature)	Alen He
Reviewer (name + signature):  Approved (name + signature):	TAT Technology Co
	****













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(Note: N/A means not applicable)







#### **VERSION** 1.

Report No.	Issue Date	Description	Approved
ZKT-2104061094E-3 Apr. 13, 2021		Original	Valid





The Product has been tested according to the following specifications:

No.	Test Parameter	Clause No	Results				
	Transmitter Parameters						
1	RF output power	4.3.2.2	PASS				
2	Power Spectral Density	4.3.2.3	PASS				
3	Duty Cycle, Tx-sequence, Tx-gap	4.3.2.4	N/A				
4	Medium Utilisation (MU) factor	4.3.2.5	N/A				
5	Adaptivity (adaptive equipment using modulations other than FHSS)	4.3.2.6	N/A				
6	Occupied Channel Bandwidth	4.3.2.7	PASS				
7	Transmitter unwanted emissions in the out-of-band domain	4.3.2.8	PASS				
8	Transmitter unwanted emissions in the spurious domain	4.3.2.9	PASS				
	Receiver Parameters						
9	Receiver spurious emissions	4.3.2.10	PASS				
10	Receiver Blocking	4.3.2.11	PASS				
11	Geo-location Capability	4.3.2.12	N/A				

Note: N/A is an abbreviation for Not Applicable and means this test intem is not applicable for this device according to the technology characteristic of device.

#### Remark:

N/A is an abbreviation for Not Applicable and means this test item is not applicable for this device according to the technology characteristic of device.

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#### 3. **MEASUREMENT UNCERTAINTY**

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Test item	uncertainty
RF frequency	1 x 10 <sup>-7</sup>
RF power, conducted	2.84.dB
Conducted spurious emission (30MHz-1GHz)	1.28dB
Conducted spurious emission (1GHz-18GHz)	1.576dB
Radiated Spurious emission (30MHz-1GHz)	4.3dB
Radiated Spurious emission (1GHz-18GHz)	4.5dB
Temperature	0.59℃
Humidity	5.3%



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#### 4. PRODUCT INFORMATION AND TEST SETUP

#### 4.1 Product Information

EUT Name: manifold gauge

Model No.: EMG-40V

Serial Model: MS-1000, MS-1000S, MS-2000, MS-2000S, MS-3000S, MS-3000S, MS-4000,

MS-4000S, EMG-10V, EMG-10VW, EMG-20V, EMG-20VW, EMG-30V,

EMG-30VW, EMG-40V, EMG-40VW

Model Description: Model name and appearance

Hardware Version: N/A

Software Version: N/A

Operation Frequency: 2402-2480MHz

Max. RF output power: 2.15dBm

Type of Modulation: GFSK

Antenna installation: PCB Antenna

Antenna Gain: 0dBi

Ratings: Input: 5V==2A,

DC3.7V 5000mAh by battery

#### 4.2 Test Setup Configuration

See test photographs attached in EUT TEST SETUP PHOTOGRAPHS for the actual connections between Product and support equipment.

4.3 Support Equipment

No.	Device Type	Brand	Model	Series No.	Data Cable	Power Cord
1.						

#### Notes:

- 1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

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#### 4.4 Channel List

CH No.	Frequency (MHz)	CH No.	Frequency (MHz)	CH No.	Frequency (MHz)	CH No.	Frequency (MHz)
0	2402	1	2404	2	2406	3	2408
4	2410	5	2412	6	2414	7	2416
8	2418	9	2420	10	2422	11	2424
12	2426	13	2428	14	2430	15	2432
16	2434	17	2436	18	2438	19	2440
20	2442	21	2444	22	2446	23	2448
24	2450	25	2452	26	2454	27	2456
28	2458	29	2460	30	2462	31	2464
32	2466	33	2468	34	2470	35	2472
36	2474	37	2476	38	2478	39	2480

#### 4.5 Test Mode

All test mode(s) and condition(s) mentioned were considered and evaluated respectively by performing full tests, the worst data were recorded and reported.

Test mode	Low channel	Middle channel	High channel
Transmitting(GFSK)	2402MHz	2440MHz	2480MHz
Receiving(GFSK)	2402MHz	2440MHz	2480MHz

#### 4.6 Test Environment

#### 1. Normal Test Conditions:

Humidity(%):	56
Atmospheric Pressure(hPa):	1010
Temperature(℃):	25.4
Test Voltage(DC):	3.7V

### 2.Extreme Test Conditions:

For tests at extreme temperatures, measurements shall be made over the extremes of the operating temperature range as declared by the manufacturer.

For tests at extreme voltages, measurements shall be made over the extremes of the power source voltage range as declared by the manufacturer.

Test Conditions	LTLV	LTHV	HTHV	HTLV
Temperature (°C)	-10	-10	50	50
Test Voltage (DC)	3.33	4.07	4.07	3.33

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#### 5. TEST FACILITY AND TEST INSTRUMENT USED

### 5.1 Test Facility

All measurement facilities used to collect the measurement data are located at ZKT Building & 1/F, No. 101, Building B, No. 6, Tangwei Community Industrial Avenue, Fuhai Street, Bao'an District, Shenzhen, China. The site and apparatus are constructed in conformance with the requirements of ANSI C63.4 and CISPR 16-1-1 other equivalent standards.

#### 5.2 Test Instrument Used

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Cal.Date	Cal.Due date
1	966 chamber	ChengYu	966 Room	966	2020.09.22	2021.09.21
2	Spectrum Analyzer	Aglient	E4407B	MY45109572	2020.09.22	2021.09.21
3	Amplifier	Schwarzbeck	BBV9718	9718-309	2020.09.22	2021.09.21
4	Amplifier	Schwarzbeck	BBV9744	9744-0037	2020.09.22	2021.09.21
5	TRILOG Broadband Antenna	schwarzbeck	VULB 9163	VULB9163-942	2020.09.22	2021.09.21
6	Horn Antenna	SCHWARZBECK	BBHA9120 D	1201	2020.09.22	2021.09.21
7	band rejection filter	ZBSF	ZBSF-C244 1.5	1706003605	2020.09.22	2021.09.21
8	Signal Generator	Keysight	N5181A	MY50143748	2020.09.22	2021.09.21
9	Communication test set	R&S	CMU200	119435	2020.09.22	2021.09.21
10	Communication test set	Agilent	N4010A	MY49081107	2020.09.22	2021.09.21
11	Spectrum Analyzer	Keysight	N9020A	MY49100060	2020.09.22	2021.09.21
12	Signal Generator	Keysight	N5182B	MY56200519	2020.09.22	2021.09.21
13	Power Sensor	Keysight	E9 300A	/	2020.09.22	2021.09.21
14	Horn antenna	SCHWARZBECK	BBHA9170	822	2020.09.22	2021.09.21
15	Preamplifier	MITEQ	TTA1840-35 -HG	2034381	2020.09.22	2021.09.21
16	Software	Frad	EZ-EMC	FA-03A2 RE	\	1
17	Software	Keysight	Keysight.ET SLTest system	1.02.05	١	1

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#### 6. **INFORMATION AS REQUIRED**

	~~~	0001	100	∆nnex F

LTSI LN 300 320 V2.2.2 AITHEX L	
a) The type of modulation used by the equipment:	
□FHSS	
☑ other forms of modulation	
b) In case of FHSS modulation:	
☐ In case of non-Adaptive Frequency Hopping equipment:	
The number of Hopping Frequencies: _	
☐ In case of Adaptive Frequency Hopping Equipment:	
The maximum number of Hopping Frequencies:	
The minimum number of Hopping Frequencies:	
☐ The (average) Dwell Time: maximum	
c) Adaptive / non-adaptive equipment:	
non-adaptive Equipment	
adaptive Equipment without the possibility to switch to a non-adaptive mode	
adaptive Equipment which can also operate in a non-adaptive mode	
d) In case of adaptive equipment:	
The Channel Occupancy Time implemented by the equipment:	
☐ The equipment has implemented an LBT based DAA mechanism	
☐ In case of equipment using modulation different from FHSS:	
The equipment is Frame Based equipment	
☐ The equipment is Load Based equipment	
The equipment can switch dynamically between Frame Based and Load Ba	ised equipment
The CCA time implemented by the equipment: µs	
The equipment has implemented an non-LBT based DAA mechanism	
The equipment can operate in more than one adaptive mode	
e) In case of non-adaptive Equipment:	
The maximum RF Output Power (e.i.r.p.):	
The maximum (corresponding) Duty Cycle:	
Equipment with dynamic behaviour, that behaviour is described here. (e.g. the difference of the property of th	erent combinations of
duty cycle and corresponding power levels to be declared):	
f) The worst case operational mode for each of the following tests:	
RF Output Power: GFSK	
Duty cycle, Tx-Sequence, Tx-gap	
Accumulated Transmit time, Frequency Occupation &	
Hopping Sequence (only for FHSS equipment):	
☐ Hopping Frequency Separation (only for FHSS equipment):	
Medium Utilization:	
Adaptivity:	
☐ Adaptivity.  ☐ Nominal Channel Bandwidth: GFSK	
☐ Transmitter unwanted emissions in the OOB domain: GFSK	
☐ Transmitter unwanted emissions in the source domain: GFSK	
Receiver spurious emissions : GFSK	
☐ Receiver spurious emissions : Gr SR ☐ Receiver blocking : GFSK	
g) The different transmit operating modes (tick all that apply):	
<ul> <li>☑ Operating mode 1: Single Antenna Equipment</li> </ul>	
Equipment with only one antenna	
☐ Equipment with two diversity antennas but only one antenna active at any mo	ment in time
☐ Smart Antenna Systems with two or more antennas, but operating in a (legacy	
One antenna is used (e.g. IEEE 802.11™ [i.3] legacy mode in smart antenna  ☐ Operating mode 2: Smart Antenna Systems - Multiple Antennas without beam for	
☐ Single spatial stream / Standard throughput / (e.g. IEEE 802.11™ [i.3] legacy	
☐ High Throughput (> 1 spatial stream) using Nominal Channel Bandwidth 1	mouc)
High Throughput (> 1 spatial stream) using Nominal Channel Bandwidth 2	
NOTE 1: Add more lines if more channel bandwidths are supported.	

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Operating mode 3: Smart Anteni	na Systems - N	Multiple Antennas	with beam forming	
☐ Single spatial stream / Standa				
☐ High Throughput (> 1 spatial s	tream) using I	Nominal Channel I	Bandwidth 1	
☐ High Throughput (> 1 spatial s	tream) using I	Nominal Channel I	Bandwidth 2	
NOTE 2: Add more lines if more ch				1
h) In case of Smart Antenna Syster	ns:	1111		
The number of Receive chains:				
The number of Transmit chains:				
symmetrical power distribution	1			
asymmetrical power distribution	n			
In case of beam forming, the maxin	num (additiona	al) beam forming g	jain:	
NOTE: The additional beam formin				
i) Operating Frequency Range(s) o				
Operating Frequency Range 1: Ref				
Operating Frequency Range 2:_				
NOTE: Add more lines if more Fred	uency Range	s are supported.		
j) Nominal Channel Bandwidth(s):	, , ,			
Nominal Channel Bandwidth 1: 1.0	6MHz Max.			
NOTE: Add more lines if more char		ns are supported.		
k) Type of Equipment (stand-alone			ce, etc.):	
⊠ Stand-alone	, ,		,	77 77
Combined Equipment (Equipment	nt where the ra	adio part is fully int	tegrated within another type	of
equipment)		,	31	
☐ Plug-in radio device (Equipment	intended for a	variety of host sy	stems)	
Other		,	,	
I) The normal and the extreme oper	rating conditi	ons that apply to	the equipment:	
Refer to section 4.6				
m) The intended combination(s) of	the radio equ	ipment power se	ettings and one or more a	ntenna
assemblies and their correspon			7/1//	
Antenna Type:				
☑ Integral Antenna (information	to be provided	in case of conduc	ted measurements)	
Antenna Gain: Refer to section 4			,	
If applicable, additional beamforr	ning gain (exc	luding basic anten	ına gain):	
☐ Temporary RF connector prov			,	
☐ No temporary RF connector p				
☐ Dedicated Antennas (equipment		connector)		
☐ Single power level with corres				816
☐ Multiple power settings and co	rresponding a	ntenna(s)		
Number of different Power Levels		. ,		
Power Level 1:				
Power Level 2:				
Power Level 3:				
NOTE 1: Add more lines in case the	e equipment h	as more power lev	vels.	
NOTE 2: These power levels are co				
For each of the Power Levels, prov				ains (G)
and the resulting e.i.r.p. levels also				, ( - )
Power Level 1:	<u> </u>		33- ( /   -   -   -   -   -   -   -   -	
Number of antenna assemblies p	rovided for thi	s power level:		
Assembly # Gair	n (dBi)	e.i.r.p.(dBm)	Part number or model nar	ne
1)				
2				
3	741			
4			7/17	

NOTE 3: Add more rows in case more antenna assemblies are supported for this power level.

Power Level 2:

Number of antenna assemblies provided for this power level:

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Assembly #	Gain (dBi)	e.i.r.p.(dBm)	Part number or model name
1			
2			
3			
4			
	in case more antenr	na assemblies are su	upported for this power level.
ower Level 3:			
umber of antenna asser	mblies provided for t	his power level:	
A	Onlin (AID!)	- 1 (-ID)	Ded work as a seed also see
Assembly #	Gain (dBi)	e.i.r.p.(dBm)	Part number or model name
1			
2			
3			
4			
OTF 5: Add more rows	in case more antenn	na assemblies are su	innorted for this power level
			upported for this power level.
The nominal voltages	s of the stand-alone	e radio equipment o	or the nominal voltages of the
	s of the stand-alone	e radio equipment o	or the nominal voltages of the
The nominal voltages combined (host) equipments Refer to section 8.	s of the stand-alone pment or test jig in	e radio equipment o case of plug-in de	or the nominal voltages of the vices:
The nominal voltages combined (host) equipments Refer to section 8.	s of the stand-alone pment or test jig in	e radio equipment o case of plug-in de	or the nominal voltages of the vices:
The nominal voltages combined (host) equipment (host) equ	s of the stand-alone pment or test jig in des available which	e radio equipment on case of plug-in de the can facilitate test	or the nominal voltages of the vices:
The nominal voltages combined (host) equipment type (etc.):	s of the stand-alone pment or test jig in des available which e.g. Bluetooth®, IE	e radio equipment o case of plug-in de h can facilitate test EEE 802.11™ [i.3], II	or the nominal voltages of the vices: ing: EEE 802.15.4™ [i.4], proprietary,
The nominal voltages combined (host) equipment type (etc.):	s of the stand-alone pment or test jig in des available which e.g. Bluetooth®, IE	e radio equipment o case of plug-in de h can facilitate test EEE 802.11™ [i.3], II	or the nominal voltages of the vices: ing: EEE 802.15.4™ [i.4], proprietary,
The nominal voltages combined (host) equipment to section 8. Describe the test moderate of the equipment type (etc.):	s of the stand-alone pment or test jig in des available which e.g. Bluetooth®, IE	e radio equipment of case of plug-in de n can facilitate test EEE 802.11™ [i.3], II erred to in clause 5	or the nominal voltages of the vices: ing: EEE 802.15.4™ [i.4], proprietary,
The nominal voltages combined (host) equipment to section 8. Describe the test mode of the equipment type (etc.):	s of the stand-alone pment or test jig in des available which e.g. Bluetooth®, IE istical analysis reference	e radio equipment of case of plug-in de h can facilitate test  EEE 802.11™ [i.3], II  erred to in clause 5	or the nominal voltages of the vices: ing: EEE 802.15.4™ [i.4], proprietary,
The nominal voltages combined (host) equipment to section 8. Describe the test mode of the equipment type (etc.):	s of the stand-alone pment or test jig in des available which e.g. Bluetooth®, IE istical analysis references reparate attachment stical analysis references	e radio equipment of case of plug-in de h can facilitate test  EEE 802.11™ [i.3], II  erred to in clause 5	or the nominal voltages of the vices: ing: EEE 802.15.4™ [i.4], proprietary,
The nominal voltages combined (host) equipment to section 8. Describe the test mode of the equipment type (etc.): If applicable, the static (to be provided as separation of the static (to be provide	s of the stand-alone pment or test jig in des available which e.g. Bluetooth®, IE istical analysis reference attachment stical analysis reference attachment)	e radio equipment of case of plug-in de h can facilitate test EEE 802.11™ [i.3], li erred to in clause 5	or the nominal voltages of the vices: ing: EEE 802.15.4™ [i.4], proprietary,
The nominal voltages combined (host) equipment to section 8. Describe the test mode of the equipment type (etc.): If applicable, the static (to be provided as separation of the static (to be provide	s of the stand-alone pment or test jig in des available which e.g. Bluetooth®, IE istical analysis reference attachment stical analysis reference attachment)	e radio equipment of case of plug-in de h can facilitate test EEE 802.11™ [i.3], li erred to in clause 5	or the nominal voltages of the vices: ing: EEE 802.15.4™ [i.4], proprietary,
The nominal voltages combined (host) equipment to section 8.  Describe the test mode of the equipment type (etc.):	s of the stand-alone pment or test jig in des available which e.g. Bluetooth®, IE istical analysis reference attachment stical analysis reference attachment) ity supported by the	e radio equipment of case of plug-in de h can facilitate testing in the case of the case	or the nominal voltages of the vices: ing: EEE 802.15.4™ [i.4], proprietary,
The nominal voltages combined (host) equipment to section 8. Describe the test mode of the equipment type (etc.):	s of the stand-alone pment or test jig in des available which e.g. Bluetooth®, IE istical analysis reference attachment stical analysis reference attachment) ity supported by the cation determined by	e radio equipment of case of plug-in de n can facilitate testing in case to in clause 5 control of the equipment:	or the nominal voltages of the vices: ing: EEE 802.15.4™ [i.4], proprietary, .4.1 q)
The nominal voltages combined (host) equipment to section 8.  Describe the test mode of the equipment type (etc.):	s of the stand-alone pment or test jig in des available which e.g. Bluetooth®, IE istical analysis reference attachment stical analysis reference attachment) ity supported by the cation determined by	e radio equipment of case of plug-in de n can facilitate testing in case to in clause 5 control of the equipment:	or the nominal voltages of the vices: ing: EEE 802.15.4™ [i.4], proprietary, .4.1 q)
The nominal voltages combined (host) equiparts (host) equ	des available which des available which e.g. Bluetooth®, IE istical analysis reference attachment stical analysis reference attachment) ity supported by the cation determined by not accessible to the	e radio equipment of case of plug-in de h can facilitate testing. EEE 802.11 <sup>TM</sup> [i.3], literred to in clause 5.  erred to in clause 5.  e equipment:  / the equipment as duser	or the nominal voltages of the vices: ing: EEE 802.15.4™ [i.4], proprietary, .4.1 q)

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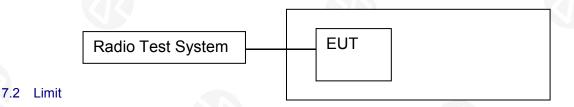


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#### 7. RF OUTPUT POWER

#### 7.1 Block Diagram Of Test Setup



For adaptive equipment using wide band modulations other than FHSS, the maximum RF output power shall be 20 dBm.

The maximum RF output power for non-adaptive equipment shall be declared by the supplier and shall not exceed 20 dBm. See clause 5.3.1 m). For non-adaptive equipment using wide band modulations other than FHSS, the maximum RF output power shall be equal to or less than the value declared by the supplier.

This limit shall apply for any combination of power level and intended antenna assembly.



#### 7.3 Test procedure

#### Step 1:

- Use a fast power sensor suitable for 2.4 GHz and capable of minimum 1 MS/s.
- Use the following settings:
- Sample speed 1 MS/s or faster.
- The samples shall represent the RMS power of the signal.
- Measurement duration: For non-adaptive equipment: equal to the observation period defined in clause 4.3.1.3.2 or clause 4.3.2.4.2. For adaptive equipment, the measurement duration shall be long enough to ensure a minimum number of bursts (at least 10) are captured.

NOTE 1: For adaptive equipment, to increase the measurement accuracy, a higher number of bursts may be used.

#### Step 2:

- For conducted measurements on devices with one transmit chain:
- Connect the power sensor to the transmit port, sample the transmit signal and store the raw data. Use these stored samples in all following steps.
- For conducted measurements on devices with multiple transmit chains:
- Connect one power sensor to each transmit port for a synchronous measurement on all transmit ports.
- Trigger the power sensors so that they start sampling at the same time. Make sure the time difference between the samples of all sensors is less than 500 ns.
- For each individual sampling point (time domain), sum the coincident power samples of all ports and store them. Use these summed samples in all following steps.

#### Step 3:

Find the start and stop times of each burst in the stored measurement samples.

The start and stop times are defined as the points where the power is at least 30 dB below the highest value of the stored samples in step 2.

NOTE 2: In case of insufficient dynamic range, the value of 30 dB may need to be reduced appropriately.

#### Step 4:

• Between the start and stop times of each individual burst calculate the RMS power over the burst using Shenzhen ZKT Technology Co., Ltd.

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the formula below. Save these Pburst values, as well as the start and stop times for each burst.

$$P_{burst} = \frac{1}{k} \sum_{n=1}^{k} P_{sample}(n)$$

with 'k' being the total number of samples and 'n' the actual sample number

### Step 5:

• The highest of all Pburst values (value "A" in dBm) will be used for maximum e.i.r.p. calculations.

### Step 6:

- Add the (stated) antenna assembly gain "G" in dBi of the individual antenna.
- If applicable, add the additional beamforming gain "Y" in dB.
- If more than one antenna assembly is intended for this power setting, the maximum overall antenna gain (G or G + Y) shall be used.
- The RF Output Power (P) shall be calculated using the formula below:

$$P = A + G + Y$$

• This value, which shall comply with the limit given in clause 4.3.1.2.3 or clause 4.3.2.2.3, shall be recorded in the test report.

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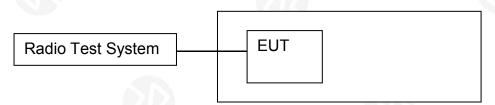
## 7.4 Test Result

	Test conditions	EIRP (dBm)			
Modulation	(Temperature)	Low Channel	Middle Channel	High Channel	
	Normal	2.08	2.15	2.13	
GFSK	Lower	2.06	2.12	2.09	
	Upper	2.03	2.13	2.11	
	Limit	<u> </u>	100mW (20dBr	n)	
Remark: P = A + G	G + Y, G=0dBi, Y=0	-			



#### 8. POWER SPECTRAL DENSITY

### 8.1 Block Diagram Of Test Setup



For equipment using wide band modulations other than FHSS, the maximum Power Spectral Density is limited to 10 dBm per MHz.



### 8.3 Test procedure

#### Step 1:

Connect the UUT to the spectrum analyser and use the following settings:

Start Frequency: 2 400 MHz

• Stop Frequency: 2 483,5 MHz

• Resolution BW: 10 kHz

· Video BW: 30 kHz

Sweep Points: > 8 350

NOTE: For spectrum analysers not supporting this number of sweep points, the frequency band may be segmented.

Detector: RMS

Trace Mode: Max Hold

• Sweep time: 10 s; the sweep time may be increased further until a value where the sweep time has no impact on the RMS value of the signal

For non-continuous signals, wait for the trace to stabilize.

Save the data (trace data) set to a file.

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### Step 2:

For conducted measurements on smart antenna systems using either operating mode 2 or operating mode 3 (see clause 5.1.3.2), repeat the measurement for each of the transmit ports. For each sampling point (frequency domain), add up the coincident power values (in mW) for the different transmit chains and use this as the new data set.

### Step 3:

Add up the values for power for all the samples in the file using the formula below.

$$P_{Sum} = \sum_{n=1}^{k} P_{sample}(n)$$

with 'k' being the total number of samples and 'n' the actual sample number

### Step 4:

Normalize the individual values for power (in dBm) so that the sum is equal to the RF Output Power (e.i.r.p.) measured in clause 5.3.2 and save the corrected data. The following formulas can be used:

$$C_{Corr} = P_{Sum} - P_{e.i.r.p.}$$

$$P_{Samplecorr}(n) = P_{Sample}(n) - C_{Corr}$$

with 'n' being the actual sample number

### Step 5:

Starting from the first sample PSamplecorr(n) (lowest frequency), add up the power (in mW) of the following samples representing a 1 MHz segment and record the results for power and position (i.e. sample #1 to sample #100). This is the Power Spectral Density (e.i.r.p.) for the first 1 MHz segment which shall be recorded.

#### Step 6:

Shift the start point of the samples added up in step 5 by one sample and repeat the procedure in step 5 (i.e. sample #2 to sample #101).

### Step 7:

Repeat step 6 until the end of the data set and record the Power Spectral Density values for each of the 1 MHz segments.

From all the recorded results, the highest value is the maximum Power Spectral Density for the UUT. This value, which shall comply with the limit given in clause 4.3.2.3.3, shall be recorded in the test report.

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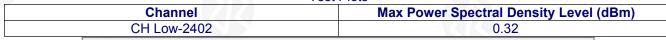


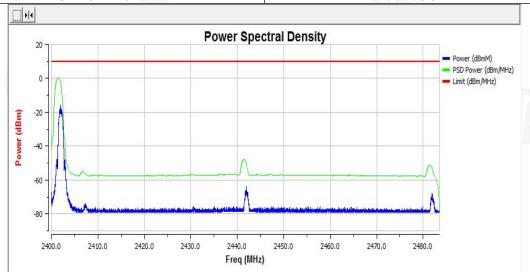


#### Test Result

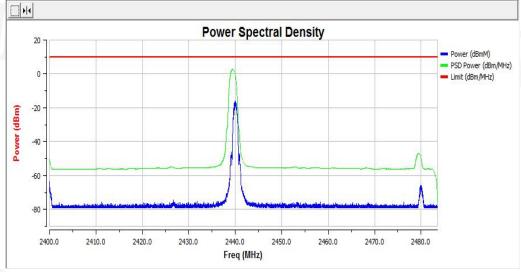
	Modulation Test conditions		Maximum e.i.r.p. Spectral Density (dBm/MHz)				
Modulation	rest conditions	Low Channel	Middle Channel	High Channel			
GFSK	Normal	0.31	2.76	2.05			
	Limit		≤10dBm/MHz				

**Test Plots** 







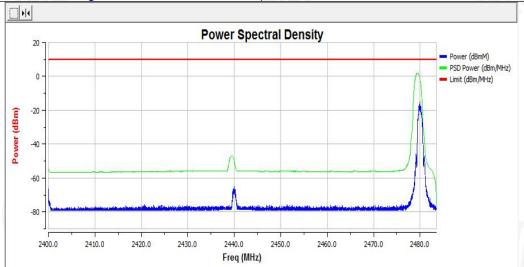


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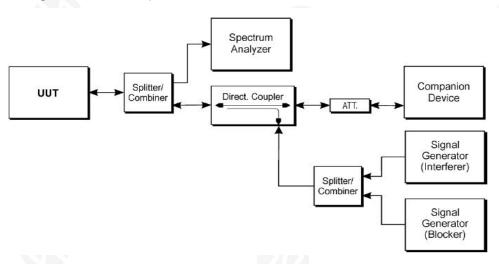






#### 9. ADAPTIVITY

### 9.1 Block Diagram Of Test Setup



#### 9.2 Limit

The frequency range of the equipment is determined by the lowest and highest

- Non-LBT based Detect and Avoid:
- 1 The frequency shall remain unavailable for a minimum time equal to 1 second after which the channel maybe considered again as an 'available' channel;
  - 2 COT ≤ 40 ms:
  - 3 Idle Period = 5% of COT:
  - 4 Detection threshold level = -70dBm/MHz + 20 Pout E.I.R.P (Pout in dBm);
- LBT based Detect and Avoid (Frame Based Equipment):
  - 1 Minimum Clear Channel Assessment (CCA) time = 20 us;
  - 2 CCA observation time declared by the supplier;
  - $3 \text{ COT} = 1 \sim 10 \text{ ms};$
  - 4 Idle Period = 5% of COT;
  - 5 Detection threshold level = -70dBm/MHz + 20 Pout E.I.R.P (Pout in dBm);
- LBT based Detect and Avoid (Load Based Equipment):
  - 1 Minimum Clear Channel Assessment (CCA) time = 20 us;
  - 2 CCA declared by the manufacturer;
  - $3 \text{ COT} \le (13 / 32) * q \text{ ms}; q = [4~32]; 1.625 \text{ms}~13 \text{ms};$
  - 4 Detection threshold level = -73dBm/MHz + 20 Pout E.I.R.P (dBm);
- **Short Control Signalling Transmissions:**

Short Control Signalling Transmissions shall have a maximum duty cycle of 10% within an observation period of 50ms.

#### 9.3 Test procedure

### Step 1:

The UUT may connect to a companion device during the test. The interference signal generator, the blocking signal generator, the spectrum analyser, the UUT and the companion device are connected using a set-up equivalent to the example given by figure 5 although the interference and blocking signal generator do not generate any signals at this point in time. The spectrum analyser is used to monitor the transmissions of the UUT in response to the interfering and the blocking signals.

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Adjust the received signal level (wanted signal from the companion device) at the UUT to the value defined in table 6

The analyzer shall be set as follows:

- RBW: ≥ Occupied Channel Bandwidth (if the analyser does not support this setting, the highest available setting shall be used)
- VBW: 3 × RBW (if the analyser does not support this setting, the highest available setting shall be used)
- Detector Mode: RMS
- Centre Frequency: Equal to the centre frequency of the operating channel
- Span: 0 Hz
- Sweep time: > Channel Occupancy Time of the UUT
- Trace Mode: Clear/Write
- Trigger Mode: Video

#### Step 2:

Configure the UUT for normal transmissions with a sufficiently high payload to allow demonstration of compliance of the adaptive mechanism on the channel being tested

Using the procedure defined in clause 5.3.7.2.1.4, it shall be verified that the UUT complies with the maximum Channel Occupancy Time and minimum Idle Period

#### **Step 3: Adding the interference signal**

A 100 % duty cycle interference signal is injected on the current operating channel of the UUT. This interference signal shall be a band limited noise signal which has a flat power spectral density, and shall have a bandwidth greater than the Occupied Channel Bandwidth of the UUT. The maximum ripple of this interfering signal shall be ±1,5 dB within the Occupied Channel Bandwidth and the power spectral density.

### Step 4: Verification of reaction to the interference signal

The spectrum analyser shall be used to monitor the transmissions of the UUT on the selected operating channel with the interfering signal injected. This may require the spectrum analyser sweep to be triggered by the start of the interfering signal.

Using the procedure defined in clause 5.3.7.2.1.4, it shall be verified that:

The UUT shall stop transmissions on the current operating channel being tested.

Apart from Short Control Signalling Transmissions (see iii) below), there shall be no subsequent transmissions on this operating channel for a (silent) period defined in clause 4.3.2.5.1.2 step 2. After that, the UUT may have normal transmissions again for the duration of a single Channel Occupancy Time period. Because the interference signal is still present, another silent period as defined in clause 4.3.2.5.1.2 step 2 needs to be included. This sequence is repeated as long as the interfering signal is present.

The UUT may continue to have Short Control Signalling Transmissions on the operating channel while the interference signal is present. These transmissions shall comply with the limits

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Alternatively, the equipment may switch to a non-adaptive mode

### Step 5: Adding the blocking signal

With the interfering signal present, a 100 % duty cycle CW signal is inserted as the blocking signal Repeat step 4 to verify that the UUT does not resume any normal transmissions

## Step 6: Removing the interference and blocking signal

On removal of the interference and blocking signal the UUT is allowed to start transmissions again on this channel however, it shall be verified that this shall only be done after the period defined in clause 4.3.2.5.1.2 step 2.

#### Step 7:

The steps 2 to 6 shall be repeated for each of the frequencies to be tested.

#### 9.4 Test Result

Remark: this requirement does not apply for equipment when operating in a mode where the RF Output power is less than 10 dBm e.i.r.p.

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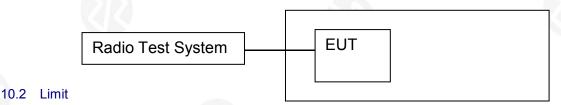
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### 10. OCCUPIED CHANNEL BANDWIDTH

#### 10.1 Block Diagram Of Test Setup



The Occupied Channel Bandwidth shall fall completely within the band given in 2.4GHz to 2.4835GHz. In addition, for non-adaptive systems using wide band modulations other than FHSS and with e.i.r.p greater than 10 dBm, the occupied channel bandwidth shall be less than 20 MHz.

#### 10.3 Test procedure

#### Step 1:

Connect the UUT to the spectrum analyser and use the following settings:

• Centre Frequency: The centre frequency of the channel under test

Resolution BW: ~ 1 % of the span without going below 1 %

• Video BW: 3 × RBW

• Frequency Span: 2 × Nominal Channel Bandwidth

Detector Mode: RMSTrace Mode: Max Hold

• Sweep time: 1 s

#### Step 2:

Wait for the trace to stabilize.

Find the peak value of the trace and place the analyser marker on this peak.

### Step 3:

Use the 99 % bandwidth function of the spectrum analyser to measure the Occupied Channel Bandwidth of the UUT.

This value shall be recorded.

NOTE: Make sure that the power envelope is sufficiently above the noise floor of the analyser to avoid the noise signals left and right from the power envelope being taken into account by this measurement.

#### 10.4 Test Result

Modulation	Frequency (MHz)	Frequenc		Occupied Channel (MHz)
0501	Low	2401.47	1	1.06
GFSK	High	1	2480.53	1.05

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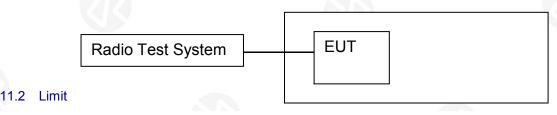






#### 11. TRANSMITTER UNWANTED EMISSIONS IN THE OUT-OF-BAND DOMAIN

### 11.1 Block Diagram Of Test Setup



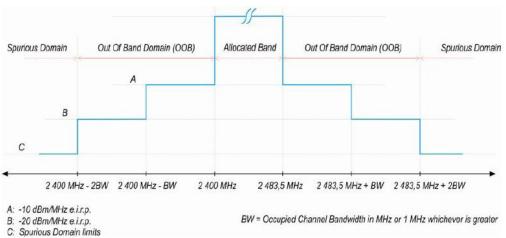


Figure 3: Transmit mask

#### 11.3 Test procedure

The applicable mask is defined by the measurement results from the tests performed under clause 5.3.8 (Occupied Channel Bandwidth).

The test procedure is further as described under clause 5.3.9.2.1.

The Out-of-band emissions within the different horizontal segments of the mask provided in figures 1 and 3 shall be measured using the steps below. This method assumes the spectrum analyser is equipped with the Time Domain Power option.

#### Step 1:

• Connect the UUT to the spectrum analyser and use the following settings:

- Centre Frequency: 2 484 MHz

- Span: 0 Hz

- Resolution BW: 1 MHz

- Filter mode: Channel filter

- Video BW: 3 MHz

- Detector Mode: RMS

- Trace Mode: Max Hold

- Sweep Mode: Continuous

- Sweep Points: Sweep Time [s] / (1  $\mu$ s) or 5 000 whichever is greater

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- Trigger Mode: Video trigger

NOTE 1: In case video triggering is not possible, an external trigger source may be used.

- Sweep Time: > 120 % of the duration of the longest burst detected during the measurement of the RF **Output Power** 

### Step 2 (segment 2 483,5 MHz to 2 483,5 MHz + BW):

- Adjust the trigger level to select the transmissions with the highest power level.
- For frequency hopping equipment operating in a normal hopping mode, the different hops will result in signal bursts with different power levels. In this case the burst with the highest power level shall be selected.
- Set a window (start and stop lines) to match with the start and end of the burst and in which the RMS power shall be measured using the Time Domain Power function.
- Select RMS power to be measured within the selected window and note the result which is the RMS power within this 1 MHz segment (2 483,5 MHz to 2 484,5 MHz). Compare this value with the applicable limit provided by the mask.
- Increase the centre frequency in steps of 1 MHz and repeat this measurement for every 1 MHz segment within the range 2 483,5 MHz to 2 483,5 MHz + BW. The centre frequency of the last 1 MHz segment shall be set to 2 483,5 MHz + BW - 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

#### Step 3 (segment 2 483,5 MHz + BW to 2 483,5 MHz + 2BW):

 Change the centre frequency of the analyser to 2 484 MHz + BW and perform the measurement for the first 1 MHz segment within range 2 483,5 MHz + BW to 2 483,5 MHz + 2BW. Increase the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 483,5 MHz + 2 BW - 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

### Step 4 (segment 2 400 MHz - BW to 2 400 MHz):

 Change the centre frequency of the analyser to 2 399,5 MHz and perform the measurement for the first 1 MHz segment within range 2 400 MHz - BW to 2 400 MHz Reduce the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 400 MHz - BW + 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

### Step 5 (segment 2 400 MHz - 2BW to 2 400 MHz - BW):

 Change the centre frequency of the analyser to 2 399,5 MHz - BW and perform the measurement for the first 1 MHz segment within range 2 400 MHz - 2BW to 2 400 MHz - BW. Reduce the centre frequency in 1 MHz steps and repeat the measurements to cover this whole range. The centre frequency of the last 1 MHz segment shall be set to 2 400 MHz - 2BW + 0,5 MHz (which means this may partly overlap with the previous 1 MHz segment).

#### Step 6:

· In case of conducted measurements on equipment with a single transmit chain, the declared antenna assembly gain "G" in dBi shall be added to the results for each of the 1 MHz segments and compared with the limits

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provided by the mask given in figure 1 or figure 3. If more than one antenna assembly is intended for this power setting, the antenna with the highest gain shall be considered.

- In case of conducted measurements on smart antenna systems (equipment with multiple transmit chains), the measurements need to be repeated for each of the active transmit chains. The declared antenna assembly gain "G" in dBi for a single antenna shall be added to these results. If more than one antenna assembly is intended for this power setting, the antenna with the highest gain shall be considered. Comparison with the applicable limits shall be done using any of the options given below:
- Option 1: the results for each of the transmit chains for the corresponding 1 MHz segments shall be added. The additional beamforming gain "Y" in dB shall be added as well and the resulting values compared with the limits provided by the mask given in figure 1 or figure 3.
- Option 2: the limits provided by the mask given in figure 1 or figure 3 shall be reduced by

 $10 \times log10$ (Ach) and the additional beamforming gain "Y" in dB. The results for each of the transmit chains shall be individually compared with these reduced limits.

NOTE 2: Ach refers to the number of active transmit chains.

It shall be recorded whether the equipment complies with the mask provided in figure 1 or figure 3.

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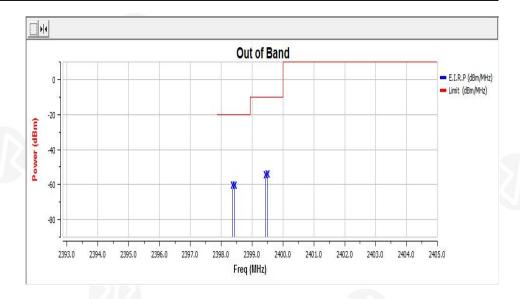


## 11.4 Test Result

Te	Test Condition		Lower Band Edge		Higher Band Edge	
Test Mode	Temp	Voltage	Segment A (dBm/MHz)	Segment B (dBm/MHz)	Segment A (dBm/MHz)	Segment B (dBm/MHz)
GFSK	Normal	Normal	-55.73	-62.34	-62.83	-63.64
	Limit		-10	-20	-10	-20
Conclusion PASS			•			
Remark: N/	A	100				

## **CH Low (Normal Temp)**

Test Freq (MHz)	Antenna	Freq(MHz)	Level	Limit
2402	Antenna 1	2399.500	-55.73	-10
2402	Antenna 1	2399.436	-56.35	-10
2402	Antenna 1	2398.436	-62.34	-20
2402	Antenna 1	2398.372	-62.48	-20

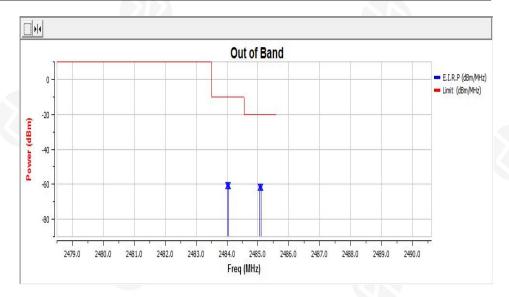






## **CH High (Normal Temp)**

Test Freq (MHz)	Antenna	Freq(MHz)	Level	Limit
2480	Antenna 1	2484.000	-62.83	-10
2480	Antenna 1	2484.055	-62.90	-10
2480	Antenna 1	2485.055	-63.77	-20
2480	Antenna 1	2485.110	-63.64	-20

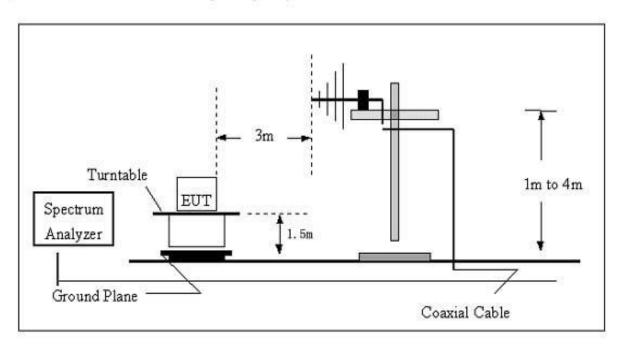




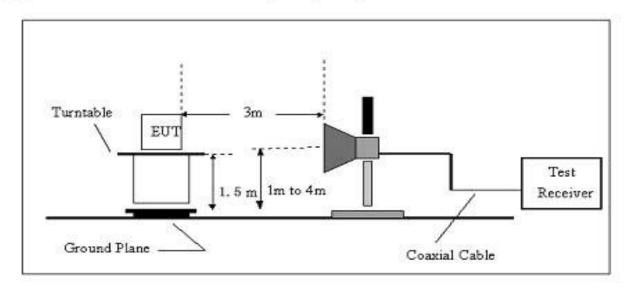
#### 12. TRANSMITTER UNWANTED EMISSIONS IN THE SPURIOUS DOMAIN

### **Block Diagram Of Test Setup**

(A) Radiated Emission Test Set-Up, Frequency Below 1000MHz



## (B) Radiated Emission Test Set-Up Frequency Above 1 GHz







#### 12.2 Limits

Maximum power, e.r.p. (≤ 1 GHz) e.i.r.p. (> 1 GHz)	RBW/VBW
-36 dBm	100 kHz/300KHz
-54 dBm	100 kHz/300KHz
-36 dBm	100 kHz/300KHz
-54 dBm	100 kHz/300KHz
-36 dBm	100 kHz/300KHz
-54 dBm	100 kHz/300KHz
-36 dBm	100 kHz/300KHz
-54 dBm	100 kHz/300KHz
-36 dBm	100 kHz/300KHz
-30 dBm	1 MHz/3MHz
	e.r.p. (≤ 1 GHz) e.i.r.p. (> 1 GHz) -36 dBm -54 dBm -36 dBm -54 dBm -36 dBm -54 dBm -54 dBm -54 dBm -36 dBm -54 dBm

#### 12.3 Test Procedure

#### 30MHz ~ 1GHz:

- a. The Product was placed on the nonconductive turntable 1.5m above the ground in a full anechoic chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

#### **Above 1GHz:**

- a. The Product was placed on the non-conductive turntable 1.5 m above the ground in a full anechoic chamber..
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.

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#### 12.4 Test Results

	Receiver	Turn	RX An	tenna	Correct	Absolute	Re	sult
Frequency	Reading	table Angle	Height	Polar	Factor	Level	Limit	Margin
(MHz)	(dBm)	Degree	(m)	(H/V)	(dBm)	(dBm)	(dBm)	(dB)
			GFSK I	ow chanr	nel			
525.47	-55.97	5	1.3	Н	-7.68	-63.65	-54	-9.65
525.47	-55.46	267	1.2	V	-7.68	-63.14	-54	-9.14
4804.00	-45.57	17	1.6	Н	-0.43	-46.00	-30	-16.00
4804.00	-43.36	356	1.9	V	-0.43	-43.79	-30	-13.79
7206.00	-60.47	73	1.4	H	8.31	-52.16	-30	-22.16
7206.00	-62.83	299	1.2	V	8.31	-54.52	-30	-24.52
			GFSK I	Mid chanı	nel			
525.47	-55.29	178	1.3	Н	-7.68	-62.97	-54	-8.97
525.47	-55.41	26	2.0	V	-7.68	-63.09	-54	-9.09
4880.00	-46.33	257	1.3	Н	-0.38	-46.71	-30	-16.71
4880.00	-44.03	28	1.3	V	-0.38	-44.41	-30	-14.41
7320.00	-59.50	312	1.2	Н	8.83	-50.67	-30	-20.67
7320.00	-62.19	323	1.4	V	8.83	-53.36	-30	-23.36
			GFSK h	igh chan	nel			
525.47	-56.64	183	1.2	Н	-7.68	-64.32	-54	-10.32
525.47	-55.64	168	1.8	V	-7.68	-63.32	-54	-9.32
4960.00	-45.12	89	1.7	Н	-0.32	-45.44	-30	-15.44
4960.00	-42.39	17	1.0	V	-0.32	-42.71	-30	-12.71
7440.00	-60.39	42	1.1	Н	9.35	-51.04	-30	-21.04
7440.00	-62.70	131	1.5	V	9.35	-53.35	-30	-23.35

Absolute Level = Receiver Reading + Factor

Factor = Antenna Factor + Cable Loss – Pre-amplifier.

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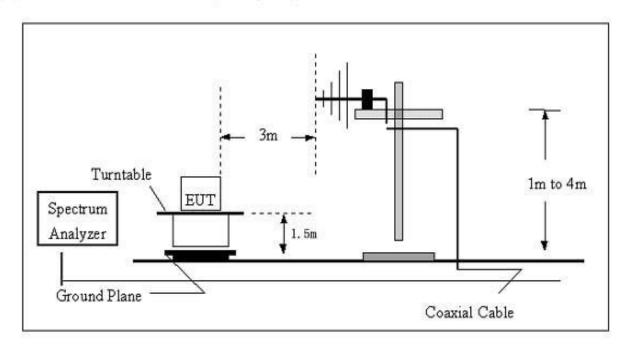




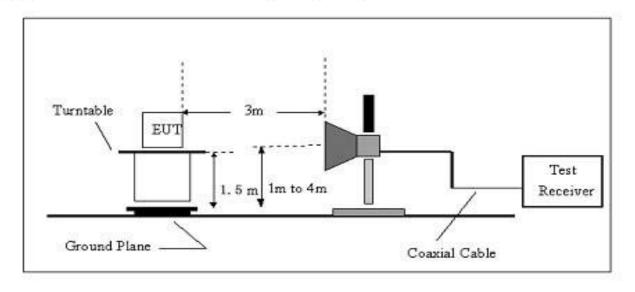
#### **RECEIVER SPURIOUS EMISSIONS**

## Block Diagram Of Test Setup

## (A) Radiated Emission Test Set-Up, Frequency Below 1000MHz



## (B) Radiated Emission Test Set-Up Frequency Above 1 GHz



# 13.2 Limits

Frequency(MHz)	Limit
30-1000	-57dBm
1000-12750	-47dBm

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#### 13.3 Test Procedure

#### 30MHz ~ 1GHz:

- a. The Product was placed on the nonconductive turntable 1.5m above the ground in a full anechoic chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

#### **Above 1GHz:**

- a. The Product was placed on the non-conductive turntable 1.5 m above the ground in a full anechoic chamber...
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.

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#### 13.4 Test Results

Frequency Receiver Reading	PACAIVAR	Turn	RX Antenna		Correct	Absolute Level	Result	
	table Angle	Height	Polar	Factor	Limit		Margin	
(MHz)	(dBm)	Degree	(m)	(H/V)	(dBm)	(dBm)	(dBm)	(dB)
	GFSK low channel							
331.69	-54.42	173	1.0	Н	-12.60	-67.02	-57.00	-10.02
331.69	-55.07	223	1.6	V	-12.60	-67.67	-57.00	-10.67
2490.74	-51.41	283	1.4	Н	-6.80	-58.21	-47.00	-11.21
2490.74	-53.35	259	1.7	V	-6.80	-60.15	-47.00	-13.15
GFSK Mid channel								
331.69	-54.37	9	1.3	Н	-12.60	-66.97	-57.00	-9.97
331.69	-55.83	198	1.8	V	-12.60	-68.43	-57.00	-11.43
2490.74	-52.34	68	1.8	Н	-6.80	-59.14	-47.00	-12.14
2490.74	-53.48	80	1.1	V	-6.80	-60.28	-47.00	-13.28
GFSK high channel								
331.69	-53.98	239	1.0	Н	-12.60	-66.58	-57.00	-9.58
331.69	-55.92	135	1.4	V	-12.60	-68.53	-57.00	-11.53
2490.74	-50.93	222	1.2	Н	-6.80	-57.73	-47.00	-10.73
2490.74	-54.15	292	2.0	V	-6.80	-60.95	-47.00	-13.95

Remark:

Absolute Level = Receiver Reading + Factor

Factor = Antenna Factor + Cable Loss – Pre-amplifier.

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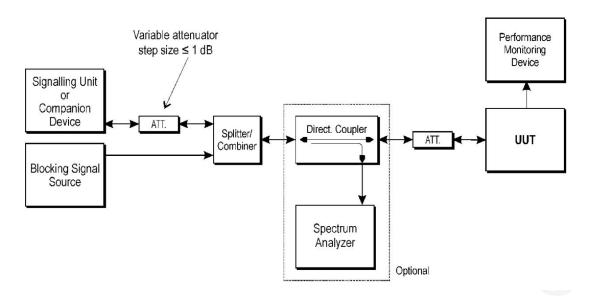






# 14. RECEIVER BLOCKING

#### 14.1 Block Diagram Of Test Setup



#### 14.2 Limit

## Receiver Category 1

Table 6 contains the Receiver Blocking parameters for Receiver Category 1 equipment.

Table 6: Receiver Blocking parameters for Receiver Category 1 equipment

Wanted signal mean power from companion device (dBm) (see notes 1 and 4)	Blocking signal frequency (MHz)	Blocking signal power (dBm) (see note 4)	Type of blocking signal	
(-133 dBm + 10 × log <sub>10</sub> (OCBW)) or -68 dBm whichever is less (see note 2)	2 380 2 504	11111111		
(-139 dBm + 10 × log <sub>10</sub> (OCBW)) or -74 dBm whichever is less (see note 3)	2 300 2 330 2 360 2 524 2 584 2 674	-34	cw	

NOTE 1: OCBW is in Hz.

NOTE 2: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to P<sub>min</sub> + 26 dB where P<sub>min</sub> is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 3: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to P<sub>min</sub> + 20 dB where P<sub>min</sub> is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 4: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna assembly gain. In case of conducted measurements, this level has to be corrected for the (in-band) antenna assembly gain (G). In case of radiated measurements, this level is equivalent to a power flux density (PFD) in front of the UUT antenna with the UUT being configured/positioned as recorded in clause 5.4.3.2.2.

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# Receiver Category 2

Table 7 contains the Receiver Blocking parameters for Receiver Category 2 equipment.

Table 7: Receiver Blocking parameters receiver Category 2 equipment

Wanted signal mean power from companion device (dBm) (see notes 1 and 3)	Blocking signal frequency (MHz)	Blocking signal power (dBm) (see note 3)	Type of blocking signal
(-139 dBm + 10 × log <sub>10</sub> (OCBW) + 10 dB) or (-74 dBm + 10 dB) whichever is less (see note 2)	2 380 2 504 2 300 2 584	-34	cw

NOTE 1: OCBW is in Hz.

NOTE 2: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative test may be performed using a wanted signal up to P<sub>min</sub> + 26 dB where P<sub>min</sub> is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 3: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna

NOTE 3: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna assembly gain. In case of conducted measurements, this level has to be corrected for the (in-band) antenna assembly gain (G). In case of radiated measurements, this level is equivalent to a power flux density (PFD) in front of the UUT antenna with the UUT being configured/positioned as recorded in clause 5.4.3.2.2.

## Receiver Category 3

Table 8 contains the Receiver Blocking parameters for Receiver Category 3 equipment.

Table 8: Receiver Blocking parameters receiver Category 3 equipment

Wanted signal mean power from companion device (dBm) (see notes 1 and 3)	Blocking signal frequency (MHz)	Blocking signal power (dBm) (see note 3)	Type of blocking signal
(-139 dBm + 10 × log <sub>10</sub> (OCBW) + 20 dB) or (-74 dBm + 20 dB) whichever is less (see note 2)	2 380 2 504 2 300 2 584	-34	cw

NOTE 1: OCBW is in Hz.

NOTE 2: In case of radiated measurements using a companion device and the level of the wanted signal from the companion device cannot be determined, a relative the test may be performed using a wanted signal up to P<sub>min</sub> + 30 dB where P<sub>min</sub> is the minimum level of wanted signal required to meet the minimum performance criteria as defined in clause 4.3.1.12.3 in the absence of any blocking signal.

NOTE 3: The level specified is the level at the UUT receiver input assuming a 0 dBi antenna assembly gain. In case of conducted measurements, this level has to be corrected for the (in-band) antenna assembly gain (G). In case of radiated measurements, this level is equivalent to a power flux density (PFD) in front of the UUT antenna with the UUT being configured/positioned as recorded in clause 5.4.3.2.2.

### 14.3 Test procedure

Refer to ETSI EN 300 328 V2.2.2 (2019-07) Clause 5.4.11.2.

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14.4 Test Result

Modulation: GFSK

Receiver Category 2							
Mode Hopping	Wanted Power(dBm)	Blocking Frequency(MHz)	Blocking Power(dB)	Type of Blocking Signal	Performance Criteria		
GFSK	-68.75	2380	-34	CW	Compliance		
GFSK	-68.79	2504	-34	CW	Compliance		
GFSK	-68.75	2300	-34	CW	Compliance		
GFSK	-68.79	2584	-34	CW	Compliance		







### 15. EUT PHOTOGRAPHS

### **EUT Photo 1**



### **EUT Photo 2**



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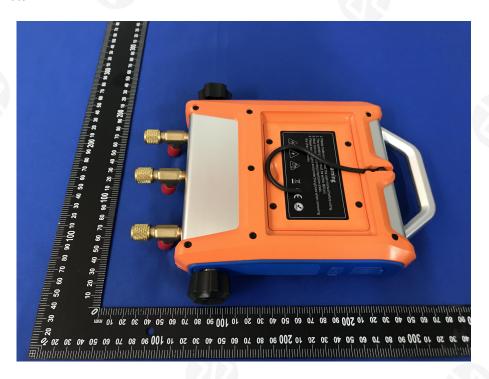












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## **EUT Photo 6**









### **EUT Photo 8**



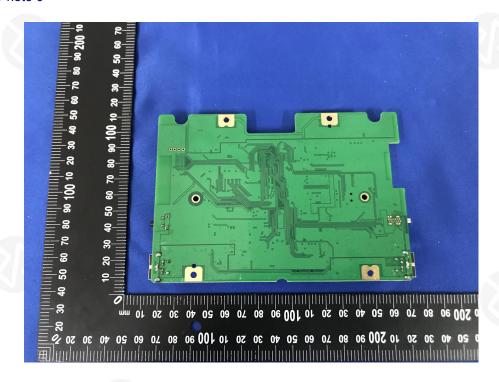
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\*\*\* \*\* END OF REPORT \*\*\*\*

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